

Search Notes

Application/Control No.

10/026,734

Examiner

Binh Q. Nguyen

Applicant(s)/Patent under
Reexamination

MACKIEWICH ET AL.

Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	395.42	9/13/2005	BQN
370	395.43	9/13/2005	BQN
370	395.53	9/13/2005	BQN
370	401	9/13/2005	BQN
370	407	9/13/2005	BQN
370	235	9/13/2005	BQN
370	392	9/13/2005	BQN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM-TDB) see search history.	9/13/2005	BQN
Consulted with Wellington Chin	9/13/2005	BQN